

# UTC UNISONIC TECHNOLOGIES CO., LTD

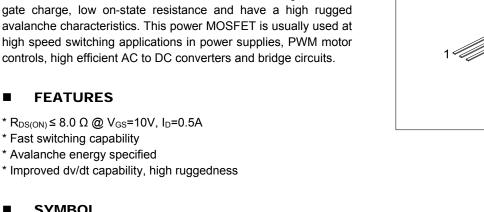
1N60-TB **Preliminary Power MOSFET** 

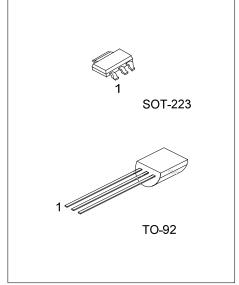
## **1.0A, 600V N-CHANNEL POWER MOSFET**

#### DESCRIPTION

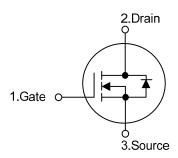
The UTC 1N60-TB is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor

- \*  $R_{DS(ON)} \le 8.0 \Omega$  @  $V_{GS} = 10V$ ,  $I_{D} = 0.5A$





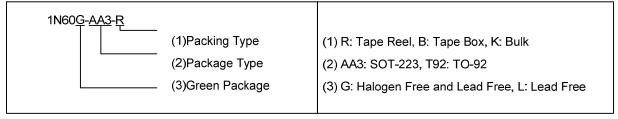
#### **SYMBOL**



#### **ORDERING INFORMATION**

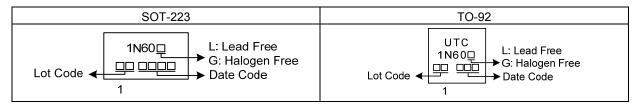
Dookin	Pin Assignment			Daakassa	Ordering Number		
Packing	3	2	1	Package	Halogen Free	Lead Free	
Tape Re	S	D	G	SOT-223	1N60G-AA3-R	1N60L-AA3-R	
Tape Bo	S	D	G	TO-92	1N60G-T92-B	1N60L-T92-B	
Bulk	S	D	G	TO-92	1N60G-T92-K	1N60L-T92-K	

Note: Pin Assignment: G: Gate D: Drain S: Source



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#### **■** MARKING



### ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub> = 25°C, unless otherwise specified)

PAF	PARAMETER		RATINGS	UNIT
rain-Source Voltage		$V_{DSS}$	600	V
Gate-Source Voltage		V <sub>GSS</sub> ±30		V
Duein Commant	Continuous	I <sub>D</sub>	1.0	Α
Drain Current	Pulsed (Note 2)	I <sub>DM</sub>	4.0	Α
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	108	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.7	V/ns
Dawar Dissination	SOT-223		8	W
Power Dissipation	TO-92	P <sub>D</sub>	1.5	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. L = 110mH,  $I_{AS}$  = 1.4A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C
- 3.  $I_{SD} \le 1.0A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

#### **■ THERMAL DATA**

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient	SOT-223	θја	150	°C/W	
	TO-92		140	°C/W	
Junction to Case	SOT-223	θјс	15.6	°C/W	
	TO-92		80	°C/W	

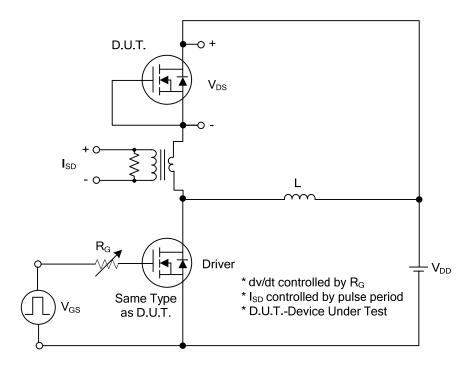
### ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		$BV_{DSS}$	$V_{GS}$ =0 $V$ , $I_D$ =250 $\mu$ A	600			V	
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V			1	μΑ	
Gate-Source Leakage Current	Forward	I <sub>GSS</sub>	$V_{GS}$ =30V, $V_{DS}$ =0V			100	nA	
	Reverse		$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Res	istance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A			8.0	Ω	
DYNAMIC CHARACTERISTICS								
Input Capacitance		$C_{ISS}$			178		pF	
Output Capacitance		Coss	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1MHz		21		pF	
Reverse Transfer Capacitance	Reverse Transfer Capacitance				3.7		pF	
SWITCHING CHARACTERISTIC	S	C <sub>RSS</sub>						
Total Gate Charge (Note 1) Gate to Source Charge Gate to Drain Charge		$Q_G$	V <sub>DS</sub> =30V, V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A, I <sub>G</sub> =100μA (Note 1, 2)		7.7		nC	
		$Q_{GS}$			1.2		nC	
		$Q_{GD}$	IG-100μΑ (Note 1, 2)		0.7		nC	
Turn-on Delay Time (Note 1)		$t_{D(ON)}$			28		ns	
Rise Time	Rise Time Turn-off Delay Time		$V_{DD}$ =30V, $V_{GS}$ =10V, $I_{D}$ =0.5A, $R_{G}$ =25 $\Omega$ (Note 1, 2)		6.4		ns	
Turn-off Delay Time					60		ns	
Fall-Time		$t_{F}$			19		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Pulsed Cur	rent	I <sub>S</sub>				1.0	Α	
Drain-Source Diode Forward Voltage (Note 1)		I <sub>SM</sub>				4.0	Α	
Maximum Body-Diode Continuous Current		$V_{\text{SD}}$	I <sub>S</sub> =0.5A, V <sub>GS</sub> =0V			1.4	V	
Reverse Recovery Time (Note 1)		t <sub>rr</sub>	I <sub>S</sub> =1.0A, V <sub>GS</sub> =0V,		150		ns	
Reverse Recovery Charge		$Q_{rr}$	dI <sub>F</sub> /dt=100A/µs		0.35		μC	

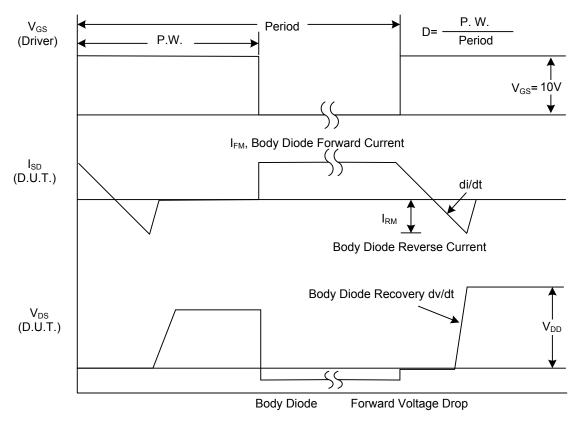
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%.

<sup>2.</sup> Essentially independent of operating temperature.

#### **■ TEST CIRCUITS AND WAVEFORMS**

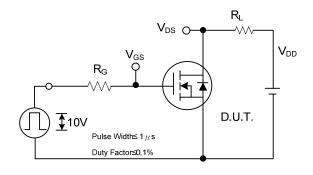


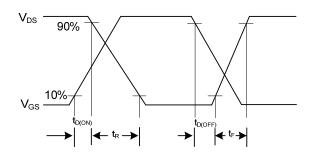
#### Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

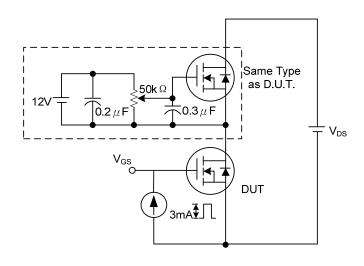
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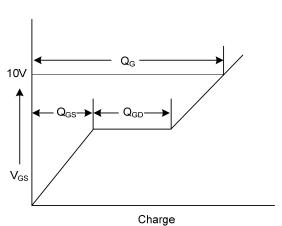




**Switching Test Circuit** 

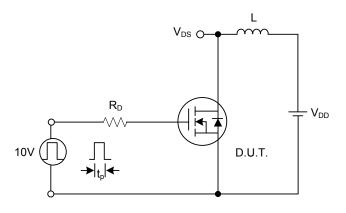
**Switching Waveforms** 

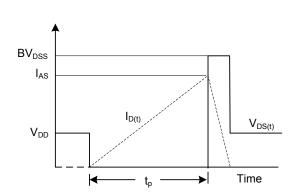




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

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